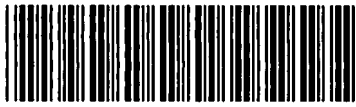


<b>Search Notes</b> 	<b>Application/Control No.</b> 10004770	<b>Applicant(s)/Patent Under Reexamination</b> LAKSONO ET AL.
	<b>Examiner</b> Huynh, Son P	<b>Art Unit</b> 2623

SEARCHED			
Class	Subclass	Date	Examiner
725	87-90,102	8/16/07	AH
386	68,83,110,111	8/16/07	AH

SEARCH NOTES		
Search Notes	Date	Examiner
East text search enclosed	8/16/07	AH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner